

## Notice of References Cited

Application/Control No.	Applicant(s)/Pater	nt Under	
10/065,895	Reexamination BROWN, ANDRE	W PHILIP	
Examiner	Art Unit .		i
Duy K Le	2685	Page 1 of 1	, t

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-2003/0044654 A1	03-2003	Holt, Laurence E.	429/13
	В	US-2002/0151320 A1	10-2002	Wasenius, Reidar	455/518
	С	US-2003/0095521 A1 -	05-2003	Haller et al.	370/338
	D	US-2002/0045454 A1	04-2002	Iwata, Shinichiro	455/450
	Е	US-6,694,143	02-2004	Beamish et al.	455/456.1
	F	US-2002/0114350 A1 -	08-2002	Tang et al.	370/469
	G	US-2002/0103863 A1 -	08-2002	Pearson, Anthony	709/204
	Н	US-2002/0068610 A1	06-2002	Anvekar et al.	455/560
	ı	US-2001/0049283 A1 *	12-2001	Thomas, Graham	455/426
	J	US-2001/0049262 A1 ·	12-2001	Lehtonen, Arto	455/41
	к	US-			
	L	US-		·	
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0			-		
	Р					
	Q					
	R					
	S					
	Т	: " <u>=</u> :				

## NON-PATENT DOCUMENTS

	,	
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	x	

A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.